

Notice of References Cited

Application/Control No.

10/566,952

Applicant(s)/Patent Under
Reexamination
GUO ET AL.

Examiner

BINH K. TIEU

Art Unit

2614

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0068545	06-2002	Oyama et al.	455/406
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